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# IRF9150

#### -25A, -100V, 0.150 Ohm, P-Channel Power MOSFET

This P-Channel enhancement mode silicon gate power field effect transistor is an advanced power MOSFET designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching convertors, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

#### Features

- -25A, -100V
- r<sub>DS(ON)</sub> = 0.150Ω
- Single Pulse Avalanche Energy Rated
- · SOA is Power Dissipation Limited
- · Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance

#### Symbol



PART NUMBER	PACKAGE	BRAND			
IRF9150	TO-204AE	IRF9150			

NOTE: When ordering, use the entire part number.

### Packaging





NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

JEDEC TO-204AE

#### Audite Sami-Canductors

## Absolute Maximum Ratings $T_{C}$ = 25°C, Unless Otherwise Specified

	IRF9150	UNITS
Drain to Source Breakdown Voltage (Note 1)	-100	V
Drain to Gate Voltage ( $R_{GS} = 20k\Omega$ ) (Note 1)	-100	V
Continuous Drain Current	-25	А
$T_{\rm C} = 100^{\circ} {\rm C}$	-18	А
Pulsed Drain Current (Note 3)	-100	А
Gate to Source Voltage	±20	V
Maximum Power Dissipation (Figure 1)	150	W
Linear Derating Factor	1.2	W/ºC
Single Pulse Avalanche Energy Rating (Note 4) E <sub>AS</sub>	1300	mJ
Avalanche Current (Repetitive or Nonrepetitive)	-25	А
Operating and Storage Temperature	-55 to 150	°C
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10sTL	300	°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

#### NOTE:

1.  $T_J = 25^{\circ}C$  to  $T_J = 125^{\circ}C$ .

#### Electrical Specifications T<sub>C</sub> = 25°C, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CON	DITIONS	MIN	ТҮР	MAX	UNITS
Drain to Source Breakdown Voltage	BV <sub>DSS</sub>	I <sub>D</sub> = -250μA, V <sub>GS</sub> = 0V, (Figure 10)		-100	. –	-	V
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = -250μA		-2	-	-4	V
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = Rated BV <sub>DSS</sub> , V <sub>GS</sub> = 0V	-	-	-25	μA	
		$V_{DS}$ = 0.8 x Rated BV <sub>DSS</sub> , $V_{GS}$ = 0V T <sub>C</sub> = 125 <sup>o</sup> C		-	-	-250	μA
On-State Drain Current (Note 2)	ID(ON)	VDS > ID(ON) X TDS(ON)MA	x, V <sub>GS</sub> = 10V	-25	-	-	А
Gate to Source Leakage Current	IGSS	V <sub>GS</sub> = ±20V		-	-	±100	nA
Drain to Source On Resistance (Note 2)	<sup>r</sup> DS(ON)	I <sub>D</sub> = -10A, V <sub>GS</sub> = -10V (Figures 8, 9)		-	0.09	0.150	Ω
Forward Transconductance (Note 2)	9fs	V <sub>DS</sub> = -10V, I <sub>D</sub> = -12.5 (Fig	ure 12)	4	10	-	S
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{DD}$ = -50V, I <sub>D</sub> = -25A, R <sub>G</sub> = 6.8 $\Omega$ , R <sub>L</sub> = 2.0 $\Omega$ , (Fig-		-	16	24	ns
Rise Time	t <sub>r</sub>	ures 17, 18) MOSFET Switching Times are Essen- tially Independent of Operating Temperature	-	110	160	ns	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	tially independent of Operating Temperature		-	65	100	ns
Fall Time	t <sub>f</sub>			-	46	70	ns
Total Gate Charge (Gate to Source + Gate to Drain)	Q <sub>g(TOT)</sub>	$V_{GS}$ = -10V, I <sub>D</sub> = -25A, V <sub>DS</sub> = 0.8 x Rated BV <sub>DSS</sub> (Figures 14, 19, 20) Gate Charge is Essentially Indpendent of Operating Temperature		-	82	120	nC
Gate to Source Charge	Qgs			-	14	-	nC
Gate to Drain "Miller" Charge	Q <sub>gd</sub>			-	42	-	nC
Input Capacitance	CISS	V <sub>DS</sub> = -25V, V <sub>GS</sub> = 0V, f = 1MHz (Figure 11)		-	2400	-	pF
Output Capacitance	COSS			-	850	-	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			•	400	-	pF
Internal Drain Inductance	LD	Measured Between the Contact Screw on the Flange that is Closer to Source and Gate Pins and the Center of Die	Modified MOSFET Symbol Showing the Internal Devices Inductances <b>P</b>	-	5.0	-	nH
Internal Source Inductance	LS	Measured From the Source Lead, 6mm (0.25in) From the Flange and the Source Bonding Pad		-	13	-	nH
Thermal Resistance Junction to Case	R <sub>0JC</sub>			-	-	0.83	°C/W
Thermal Resistance Junction to Ambient	R <sub>0JA</sub>	Free Air Operation		-	-	30	°C/W

PARAMETER	SYMBOL	L TEST CONDITIONS		TYP	MAX	UNITS
Continuous Source to Drain Current	ISD	Modified MOSFET Symbol	<u> </u>	-	-25	A
Pulse Source to Drain Current (Note 3)	ISDM	Showing the Integral Reverse P-N Junction Diode		-	-100	A
Source to Drain Diode Voltage(Note 2)	V <sub>SD</sub>	$T_{C} = 25^{\circ}C$ , $I_{SD} = 25A$ , $V_{GS} = 0V$ (Figure 2	13) -	0.9	1.5	v
Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25^{o}C$ , $I_{SD} = 25A$ , $dI_{SD}/dt = 100A/\mu s$	-	150	300	ns
Reverse Recovery Charge	Q <sub>RR</sub>	T <sub>J</sub> = 25 <sup>o</sup> C, I <sub>SD</sub> = 25A, dI <sub>SD</sub> /dt = 100A/μs	0.3	0.7	1.5	μC

#### Source to Drain Diode Specifications

NOTES:

2. Pulse test: pulse width  $\leq 300 \mu$ s, duty cycle  $\leq 2\%$ .

3. Repetitive rating: pulse width limited by maximum junction temperature. See Transient Thermal Impedance curve (Figure 3).

4.  $V_{DD}$  = 25V, starting T<sub>J</sub> = 25<sup>o</sup>C, L = 3.2mH, R<sub>G</sub> = 25 $\Omega$ , peak I<sub>AS</sub> = 25A See Figures 15, 16.

Typical Performance Curves Unless Otherwise Specified









